

**30 V, 48 A, 5.2 mΩ Low R<sub>DS(ON)</sub>  
N ch Trench Power MOSFET  
DKI03062**

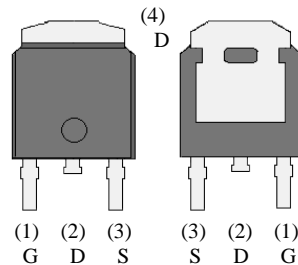


## Features

- $V_{(BR)DSS}$  ----- 30 V ( $I_D = 100 \mu A$ )
- $I_D$  ----- 48 A
- $R_{DS(ON)}$  ----- 6.5 mΩ max. ( $V_{GS} = 10$  V,  $I_D = 31$  A)
- $Q_g$  ----- 9.3 nC ( $V_{GS} = 4.5$  V,  $V_{DS} = 15$  V,  $I_D = 39.5$  A)
- Low Total Gate Charge
- High Speed Switching
- Low On-Resistance
- Capable of 4.5 V Gate Drive
- 100 % UIL Tested
- RoHS Compliant

## Package

TO-252

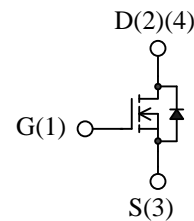


Not to scale

## Applications

- DC-DC converters
- Synchronous Rectification
- Power Supplies

## Equivalent circuit



## Absolute Maximum Ratings

- Unless otherwise specified,  $T_A = 25^\circ C$

Parameter	Symbol	Test conditions	Rating	Unit
Drain to Source Voltage	$V_{DS}$		30	V
Gate to Source Voltage	$V_{GS}$		$\pm 20$	V
Continuous Drain Current	$I_D$	$T_C = 25^\circ C$	48	A
Pulsed Drain Current	$I_{DM}$	$PW \leq 100\mu s$ Duty cycle $\leq 1\%$	96	A
Continuous Source Current (Body Diode)	$I_S$		48	A
Pulsed Source Current (Body Diode)	$I_{SM}$	$PW \leq 100\mu s$ Duty cycle $\leq 1\%$	96	A
Single Pulse Avalanche Energy	$E_{AS}$	$V_{DD} = 20$ V, $L = 1$ mH, $I_{AS} = 5.5$ A, unclamped, $R_G = 4.7 \Omega$ Refer to Figure 1	47	mJ
Avalanche Current	$I_{AS}$		13.3	A
Power Dissipation	$P_D$	$T_C = 25^\circ C$	37	W
Operating Junction Temperature	$T_J$		150	$^\circ C$
Storage Temperature Range	$T_{STG}$		- 55 to 150	$^\circ C$

## Thermal Characteristics

- Unless otherwise specified,  $T_A = 25\text{ }^{\circ}\text{C}$

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Thermal Resistance (Junction to Case)	$R_{\theta JC}$		—	—	3.4	$^{\circ}\text{C}/\text{W}$
Thermal Resistance (Junction to Ambient)	$R_{\theta JA}$	Mounted on PCB*	—	—	35.7	$^{\circ}\text{C}/\text{W}$

\* 1 inch square 2 oz copper pad on  $1.5 \times 1.5$  inch PCB.

## Electrical Characteristics

- Unless otherwise specified,  $T_A = 25\text{ }^{\circ}\text{C}$

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = 100\text{ }\mu\text{A}$ , $V_{GS} = 0\text{ V}$	30	—	—	V
Drain to Source Leakage Current	$I_{DSS}$	$V_{DS} = 30\text{ V}$ , $V_{GS} = 0\text{ V}$	—	—	100	$\mu\text{A}$
Gate to Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20\text{ V}$	—	—	$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 350\text{ }\mu\text{A}$	1.0	2.0	2.5	V
Static Drain to Source On-Resistance	$R_{DS(on)}$	$I_D = 31\text{ A}$ , $V_{GS} = 10\text{ V}$	—	5.2	6.5	m $\Omega$
		$I_D = 15.5\text{ A}$ , $V_{GS} = 4.5\text{ V}$	—	7.2	10.5	m $\Omega$
Gate Resistance	$R_G$	$f = 1\text{ MHz}$	—	2.3	—	$\Omega$
Input Capacitance	$C_{iss}$	$V_{DS} = 15\text{ V}$ $V_{GS} = 0\text{ V}$ $f = 1\text{ MHz}$	—	1480	—	pF
Output Capacitance	$C_{oss}$		—	380	—	
Reverse Transfer Capacitance	$C_{rss}$		—	180	—	
Total Gate Charge ( $V_{GS} = 10\text{ V}$ )	$Q_{g1}$	$V_{DS} = 15\text{ V}$ $I_D = 39.5\text{ A}$	—	20.6	—	nC
Total Gate Charge ( $V_{GS} = 4.5\text{ V}$ )	$Q_{g2}$		—	9.3	—	
Gate to Source Charge	$Q_{gs}$		—	3.3	—	
Gate to Drain Charge	$Q_{gd}$		—	4.2	—	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 15\text{ V}$ $I_D = 39.5\text{ A}$ $V_{GS} = 10\text{ V}$ , $R_G = 4.7\text{ }\Omega$ Refer to Figure 2	—	2.8	—	ns
Rise Time	$t_r$		—	4.5	—	
Turn-Off Delay Time	$t_{d(off)}$		—	12.8	—	
Fall Time	$t_f$		—	9.8	—	
Source to Drain Diode Forward Voltage	$V_{SD}$	$I_S = 31\text{ A}$ , $V_{GS} = 0\text{ V}$	—	0.9	1.5	V
Source to Drain Diode Reverse Recovery Time	$t_{rr}$	$I_F = 39.5\text{ A}$ $di/dt = 100\text{ A}/\mu\text{s}$ Refer to Figure 3	—	28.5	—	ns
Source to Drain Diode Reverse Recovery Charge	$Q_{rr}$		—	26.2	—	nC

## Test Circuits and Waveforms

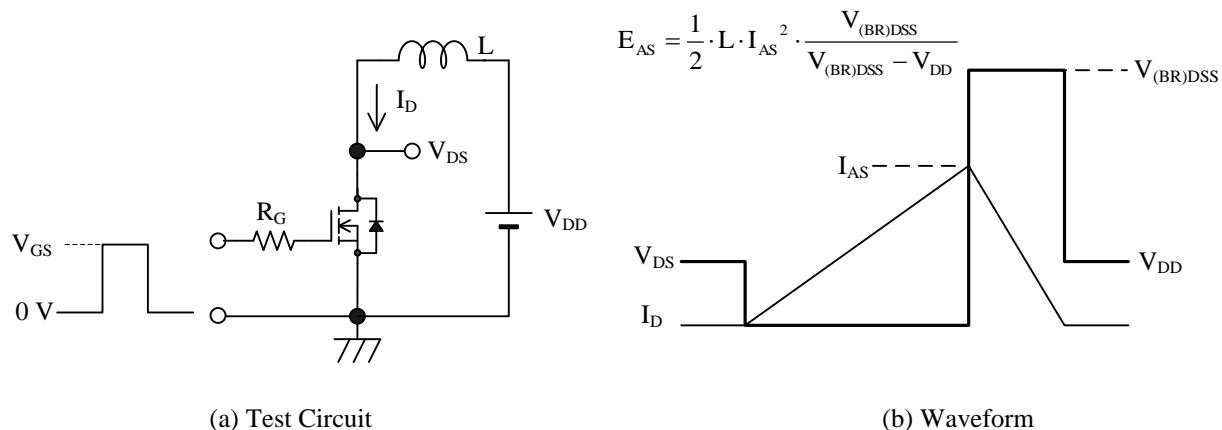


Figure 1 Unclamped Inductive Switching

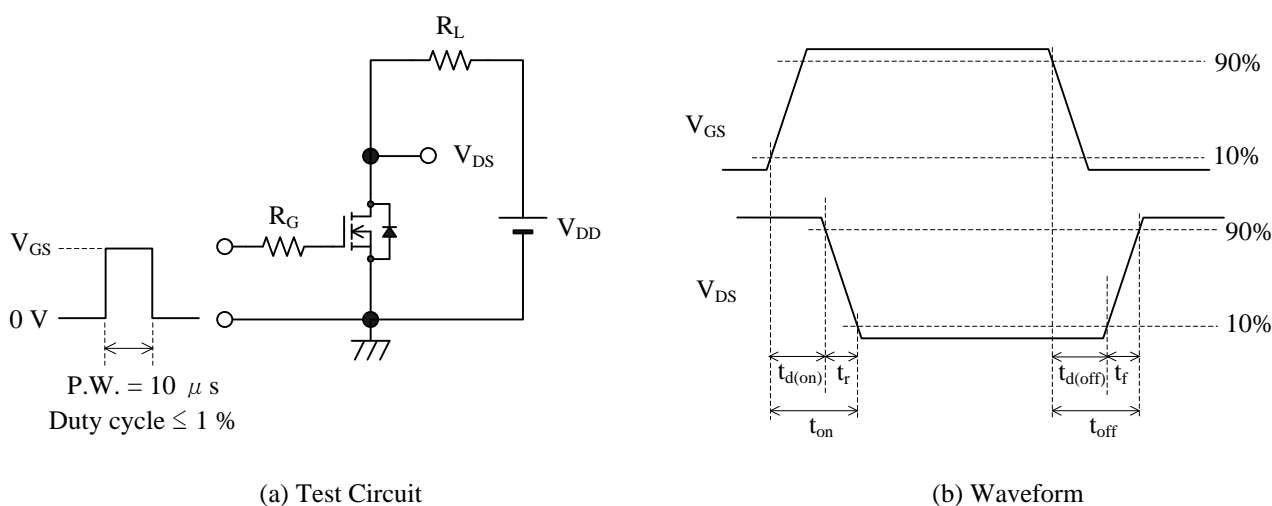


Figure 2 Switching Time

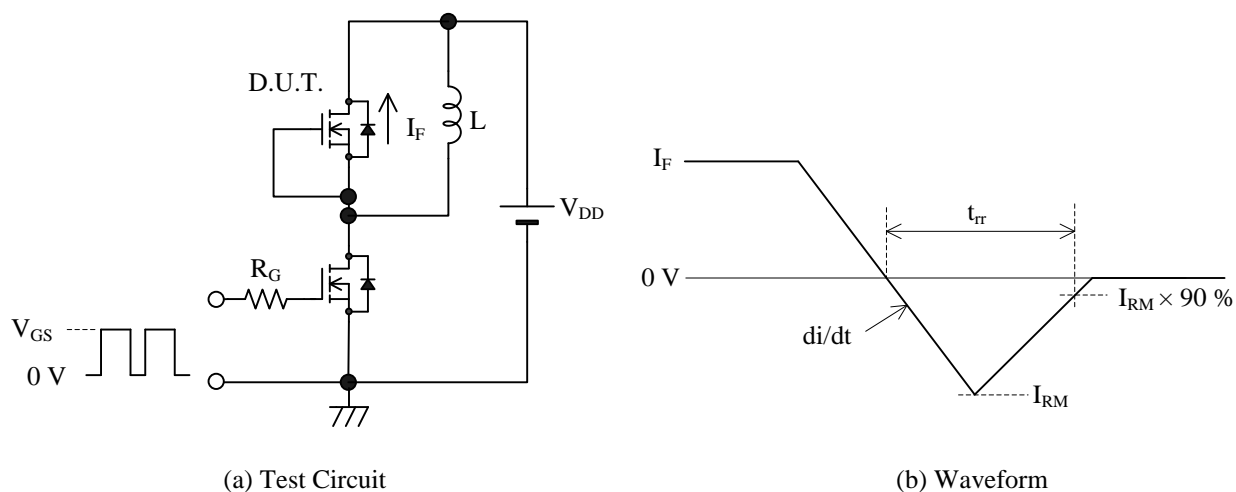
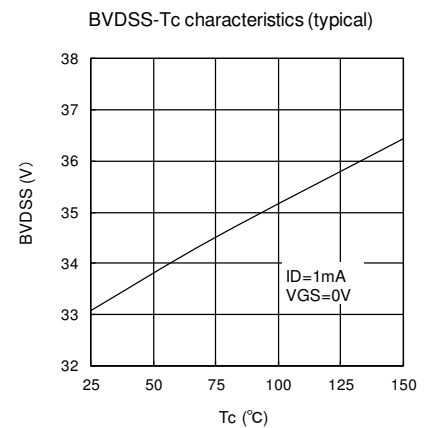
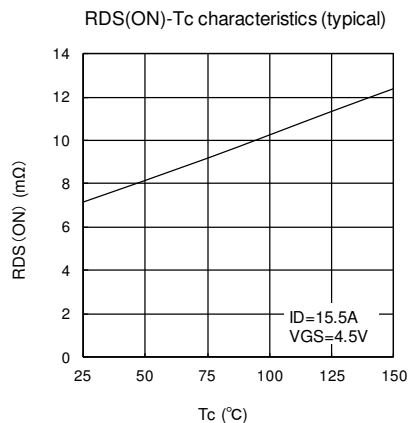
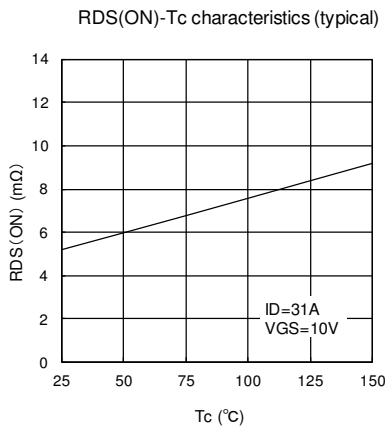
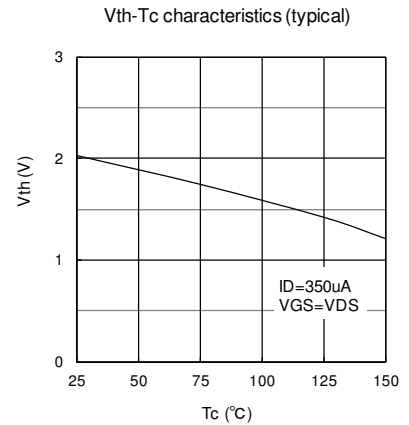
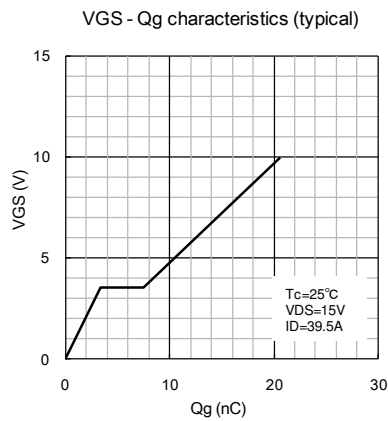
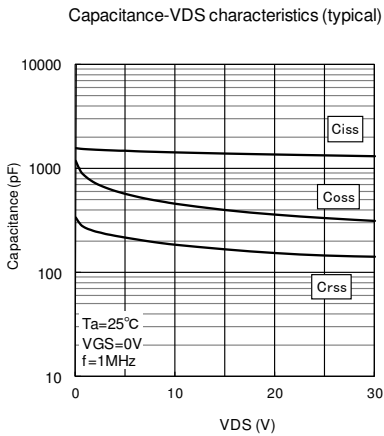
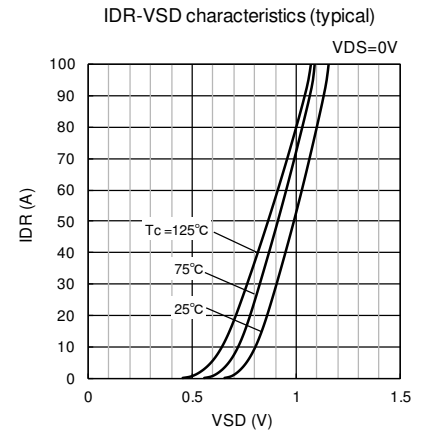
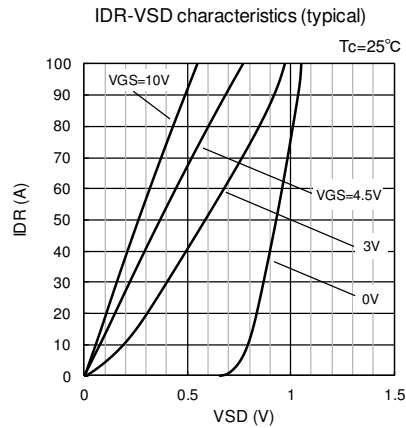
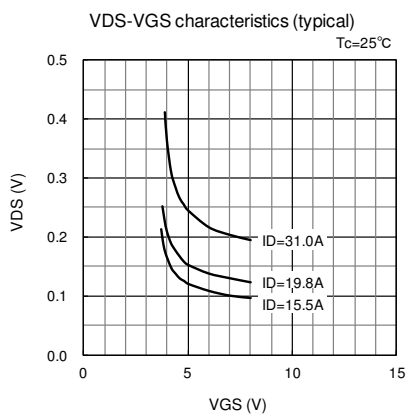
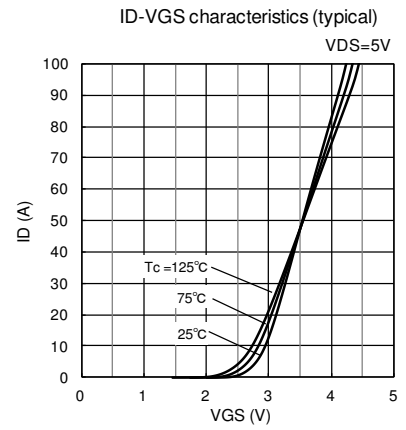
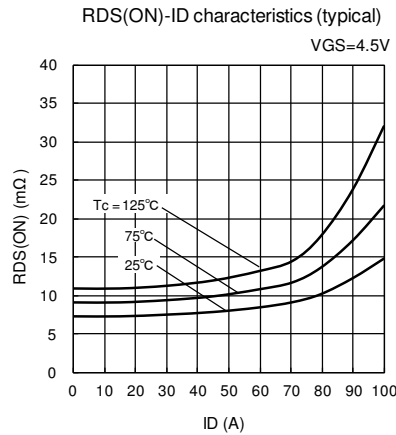
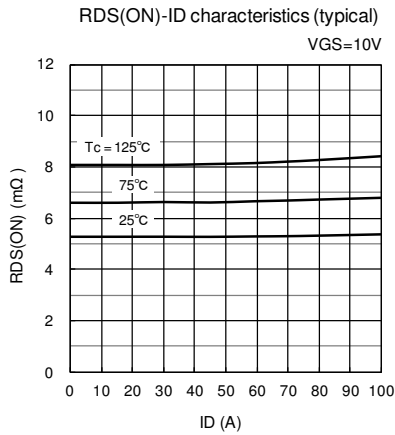
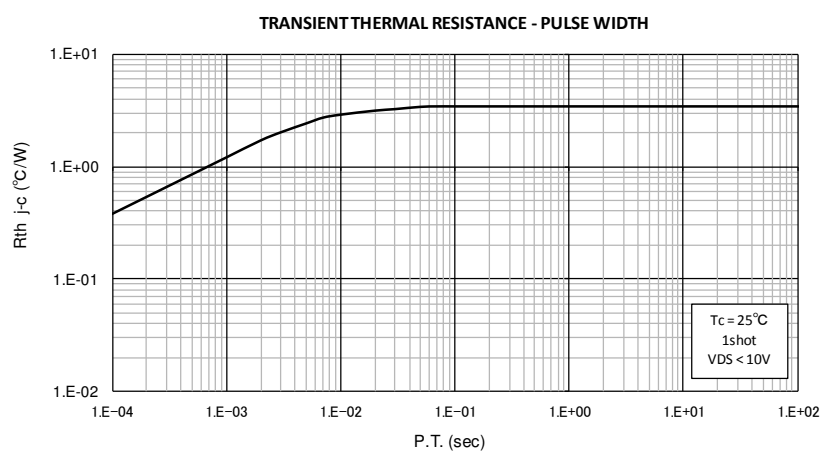
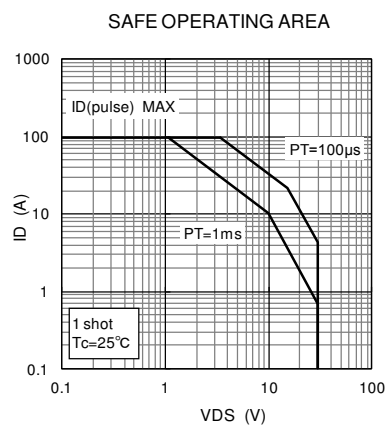
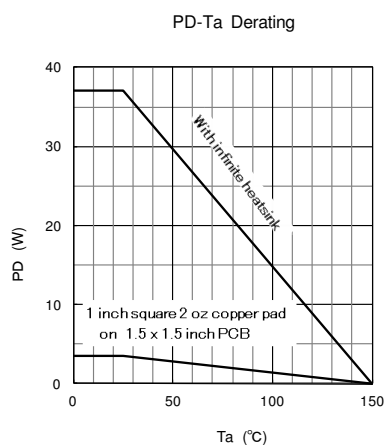


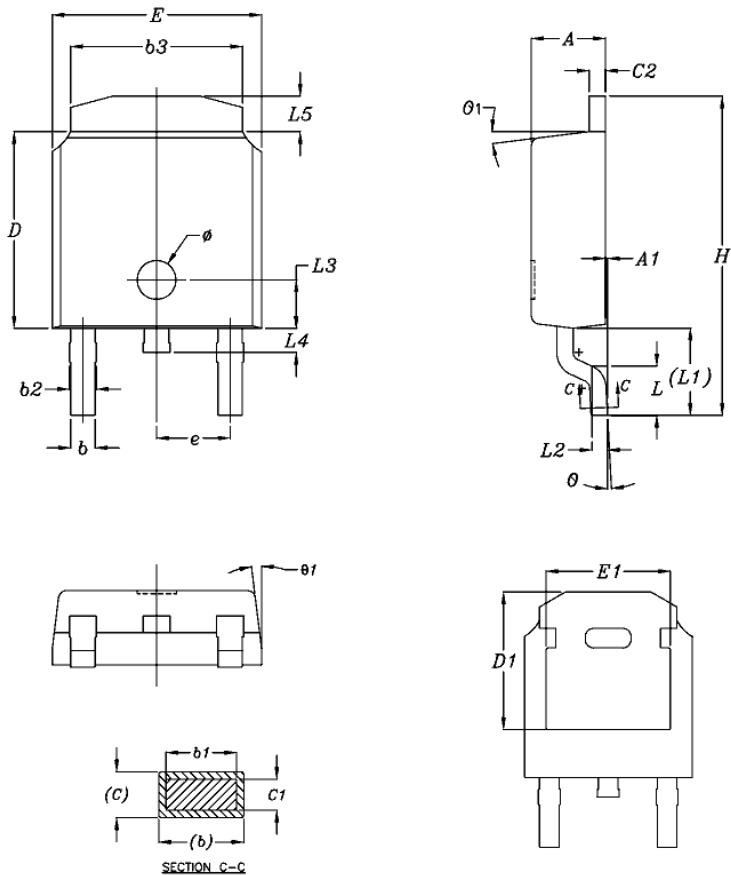
Figure 3 Diode Reverse Recovery Time





Package Outline

TO252

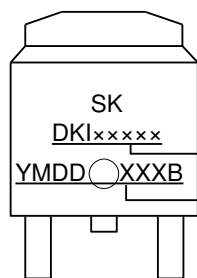


Symbol	Min.	Max.
A	2.18	2.39
A1	--	0.13
b	0.70	0.89
b1	0.70	0.86
b2	0.76	1.14
b3	4.95	5.46
c	0.46	0.61
c1	0.41	0.56
c2	0.46	0.89
D	5.97	6.22
D1	5.21	--
E	6.35	6.73
E1	4.32	--
e	2.29	
H	9.40	10.41
L	1.40	1.78
L1	2.60	2.90
L2	0.51	
L3	1.65	1.95
L4	0.60	0.90
L5	0.89	1.27
$\theta$	1°	5°
$\theta$ 1	7° REF	
$\phi$	1.20 REF	

NOTES:

- 1) Dimension is in millimeters
- 2) Pb-free. Device composition compliant with the RoHS directive

Marking Diagram



Part Number

Lot Number

Y is the Last digit of the year (0 to 9)

M is the Month (1 to 9, O, N or D)

DD is the Date (two digit of 01 to 31)

XXX is the suffix No.

B expresses Pb free pins

## OPERATING PRECAUTIONS

In the case that you use Sanken products or design your products by using Sanken products, the reliability largely depends on the degree of derating to be made to the rated values. Derating may be interpreted as a case that an operation range is set by derating the load from each rated value or surge voltage or noise is considered for derating in order to assure or improve the reliability. In general, derating factors include electric stresses such as electric voltage, electric current, electric power etc., environmental stresses such as ambient temperature, humidity etc. and thermal stress caused due to self-heating of semiconductor products. For these stresses, instantaneous values, maximum values and minimum values must be taken into consideration. In addition, it should be noted that since power devices or IC's including power devices have large self-heating value, the degree of derating of junction temperature affects the reliability significantly.

Because reliability can be affected adversely by improper storage environments and handling methods, please observe the following cautions.

### Cautions for Storage

- Ensure that storage conditions comply with the standard temperature (5 to 35°C) and the standard relative humidity (around 40 to 75%); avoid storage locations that experience extreme changes in temperature or humidity.
- Avoid locations where dust or harmful gases are present and avoid direct sunlight.
- Reinspect for rust on leads and solderability of the products that have been stored for a long time.

### Cautions for Testing and Handling

When tests are carried out during inspection testing and other standard test periods, protect the products from power surges from the testing device, shorts between the product pins, and wrong connections. Ensure all test parameters are within the ratings specified by Sanken for the products.

### Remarks About Using Thermal Silicone Grease

- When thermal silicone grease is used, it shall be applied evenly and thinly. If more silicone grease than required is applied, it may produce excess stress.
- The thermal silicone grease that has been stored for a long period of time may cause cracks of the greases, and it cause low radiation performance. In addition, the old grease may cause cracks in the resin mold when screwing the products to a heatsink.
- Fully consider preventing foreign materials from entering into the thermal silicone grease. When foreign material is immixed, radiation performance may be degraded or an insulation failure may occur due to a damaged insulating plate.
- The thermal silicone greases that are recommended for the resin molded semiconductor should be used. Our recommended thermal silicone grease is the following, and equivalent of these.

Type	Suppliers
G746	Shin-Etsu Chemical Co., Ltd.
YG6260	Momentive Performance Materials Japan LLC
SC102	Dow Corning Toray Co., Ltd.

### Soldering

When soldering the products, please be sure to minimize the working time, within the following limits:

- Reflow      Preheat ; 180 °C / 90 ± 30 s  
                 Solder heating ; 250 °C / 10 ± 1s (260 °C peak, 2 times)
- Soldering iron ; 380 ± 10 °C / 3.5 ± 0.5s (1 time)

### Electrostatic Discharge

- When handling the products, the operator must be grounded. Grounded wrist straps worn should have at least 1MΩ of resistance from the operator to ground to prevent shock hazard, and it should be placed near the operator.
- Workbenches where the products are handled should be grounded and be provided with conductive table and floor mats.
- When using measuring equipment such as a curve tracer, the equipment should be grounded.
- When soldering the products, the head of soldering irons or the solder bath must be grounded in order to prevent leak voltages generated by them from being applied to the products.
- The products should always be stored and transported in Sanken shipping containers or conductive containers, or be wrapped in aluminum foil.

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